MOSFET – Power, Single, N-Channel 40 V, 1.3 m Ω , 235 A

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS5C426NWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit		
Drain-to-Source Voltage			V_{DSS}	40	V		
Gate-to-Source Voltage			V _{GS}	±20	V		
Continuous Drain		T _C = 25°C	I _D	235	Α		
Current R _{θJC} (Notes 1, 3)	Steady	T _C = 100°C		166			
Power Dissipation	State	T _C = 25°C	P _D	128	W		
R _{θJC} (Note 1)		T _C = 100°C		64			
Continuous Drain	Steady State	T _A = 25°C	I _D	41	Α		
Current R _{0JA} (Notes 1, 2, 3)		T _A = 100°C		29			
Power Dissipation		T _A = 25°C	P_{D}	3.8	W		
R _{θJA} (Notes 1 & 2)		T _A = 100°C		1.9			
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I _{DM}	900	Α		
Operating Junction and Storage Temperature		T _J , T _{stg}	-55 to + 175	°C			
Source Current (Body Diode)			IS	122	Α		
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 19 A)		E _{AS}	739	mJ			
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)						260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	1.2	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

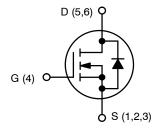
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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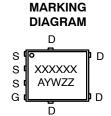
V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40 V	1.3 m Ω @ 10 V	235 A



N-CHANNEL MOSFET



DFN5 (SO-8FL) CASE 488AA STYLE 1



XXXXXX = 5C426N

(NVMFS5C426N) or

426NWF

(NVMFS5C426NWF) = Assembly Location

Y = Year
W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

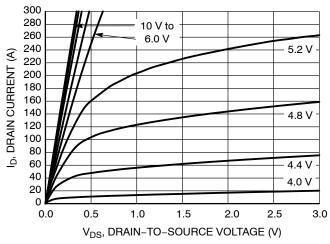
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS	•			-	<u>-</u>	-	-	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μA		40			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				9.6		mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			10		
		$V_{DS} = 40 \text{ V}$ $T_{J} = 125^{\circ}$				100	μΑ	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA	
ON CHARACTERISTICS (Note 4)								
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 170 μΑ	2.5		3.5	V	
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-8.6		mV/°C	
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V I _D = 50 A			1.1	1.3	mΩ	
Forward Transconductance	9FS	V _{DS} =15 V, I _D = 50 A			145		S	
CHARGES, CAPACITANCES & GATE RE	SISTANCE							
Input Capacitance	C _{ISS}	$V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}, V_{DS} = 25 \text{ V}$ $V_{GS} = 10 \text{ V}, V_{DS} = 20 \text{ V}; I_D = 50 \text{ A}$			4300		pF nC	
Output Capacitance	C _{OSS}				2100			
Reverse Transfer Capacitance	C _{RSS}				59			
Total Gate Charge	Q _{G(TOT)}				65			
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 20 V; I _D = 50 A			13			
Gate-to-Source Charge	Q_{GS}				20			
Gate-to-Drain Charge	Q_{GD}				12			
Plateau Voltage	V _{GP}				4.7		V	
SWITCHING CHARACTERISTICS (Note 5)							
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 20 V, I_{D} = 50 A, R_{G} = 2.5 Ω			15		- ns	
Rise Time	t _r				47			
Turn-Off Delay Time	t _{d(OFF)}				36			
Fall Time	t _f				9.0			
DRAIN-SOURCE DIODE CHARACTERIS	TICS							
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.82	1.2	.,,	
		$I_S = 50 \text{ A}$	T _J = 125°C		0.68		·	
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V, dIS/dt} = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 50 \text{ A}$			63		ns	
Charge Time	ta				34			
Discharge Time	t _b				29			
Reverse Recovery Charge	Q _{RR}				92		nC	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

^{5.} Switching characteristics are independent of operating junction temperatures.

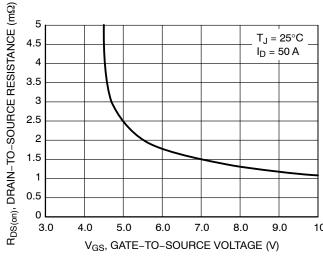
TYPICAL CHARACTERISTICS



300 $V_{DS} = 10 V$ 280 260 240 ID, DRAIN CURRENT (A) 220 200 180 160 140 120 100 80 $T_J = 25^{\circ}C$ 60 40 20 $T_{\rm J} = 125^{\circ}{\rm C}$ T_J = -55°C 0 7 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



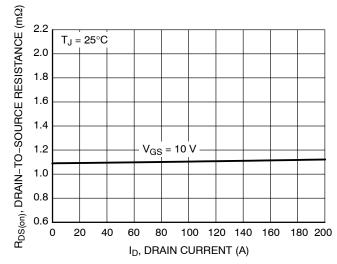
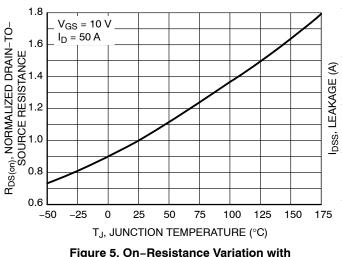


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



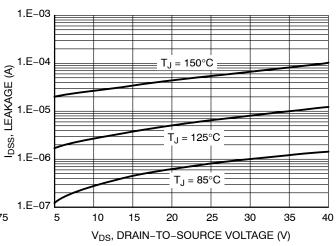


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

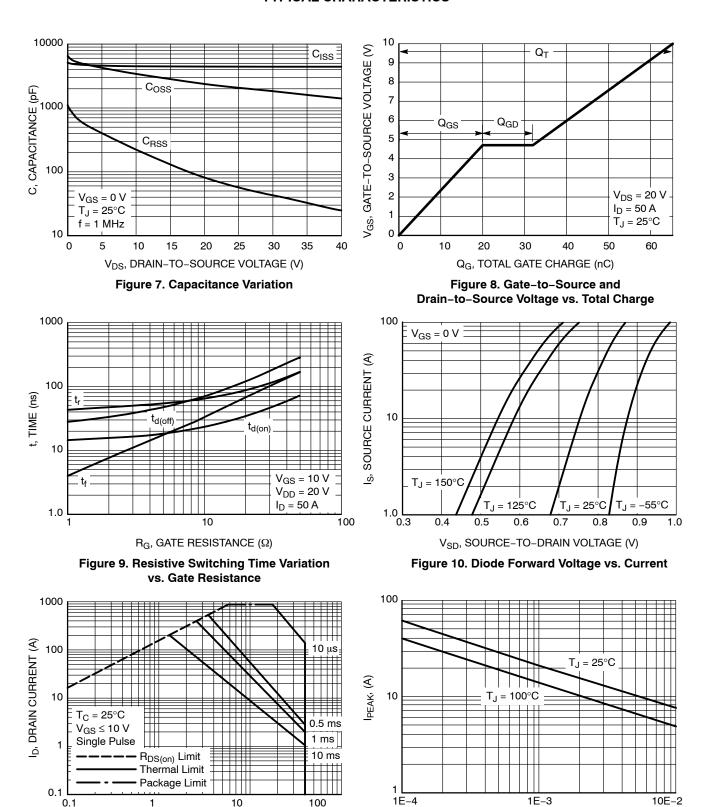


Figure 12. I_{PEAK} vs. Time in Avalanche

TIME IN AVALANCHE (s)

V_{DS}, DRAIN-TO-SOURCE VOLTAGE (V)

Figure 11. Safe Operating Area

TYPICAL CHARACTERISTICS

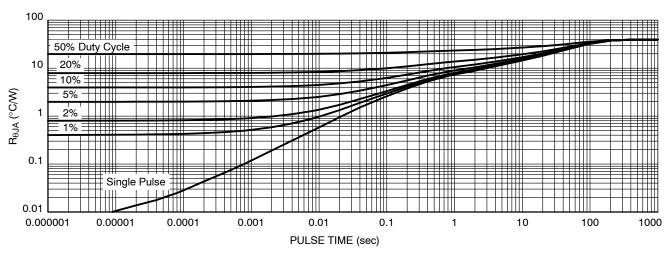


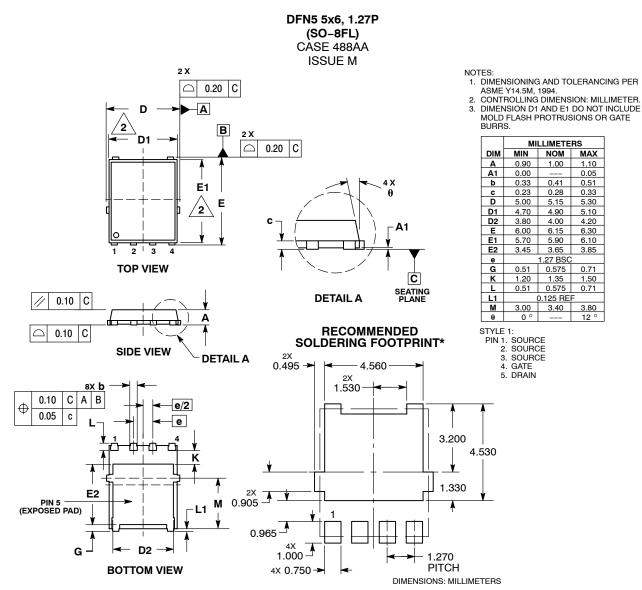
Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]	
NVMFS5C426NT1G	5C426N	DFN5 (Pb-Free)	1500 / Tape & Reel	
NVMFS5C426NWFT1G	426NWF	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel	
NVMFS5C426NT3G	5C426N	DFN5 (Pb-Free)	5000 / Tape & Reel	
NVMFS5C426NWFT3G	426NWF	DFN5 (Pb-Free, Wettable Flanks)	5000 / Tape & Reel	
NVMFS5C426NAFT1G	5C426N	DFN5 (Pb-Free)	1500 / Tape & Reel	
NVMFS5C426NWFAFT1G	426NWF	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel	

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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